Se	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/650,152	LEE ET AL.	
Examiner	Art Unit	
David B. Lugo	2611	

SEARCHED				
Class	Subclass	Date	Examiner	
375	259, 260 267, 295 299	1/7/2007	DL	
Update	search	6/10/2007	DL	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
375	259, 260	6/10/2007	DL		
375	267, 295	6/10/2007	DL		
375	299	6/10/2007	DL		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor search East search	1/7/2007	DL
Update east search	6/10/2007	DL